L Number	Hits	Search Text	DB	Time stamp
1	424	(257/329).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/19 16:11
2	673	(257/330).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/19 17:12
3	312	(257/331).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/19 17:32
4	532	(257/328).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/19 17:41

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L Number	Hits	Search Text	DB	Time stamp
1	99345	semiconductor and gate and source and drain	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/19 18:10
2	231	(semiconductor and gate and source and drain) and borderless	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/10/19 18:10

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